

Search Notes

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Examiner

Hai C. Pham

Applicant(s)/Patent under
Reexamination

SERIZAWA ET AL.

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	234-235, 241-242, 245, 248	1/7/2006	HP
	250, 263		
	256-257		
359	18	1/7/2006	HP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text Search	1/7/2006	HP